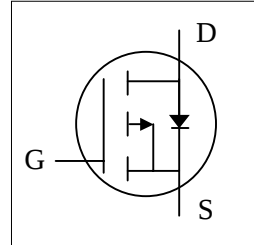


- ▼ Low Gate Charge
- ▼ Fast Switching Characteristic
- ▼ Simple Drive Requirement
- ▼ RoHS Compliant & Halogen-Free

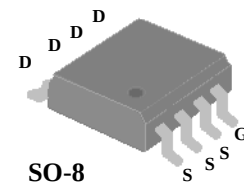


BV_{DSS}	-100V
$R_{DS(ON)}$	135mΩ
I_D^3	-3A

Description

XP10P135 series are innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

The SO-8 package is widely preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.



Absolute Maximum Ratings@ $T_J=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	-100	V
V_{GS}	Gate-Source Voltage	+20	V
$I_D@T_A=25^\circ\text{C}$	Drain Current, $V_{GS} @ 10V^3$	-3	A
$I_D@T_A=70^\circ\text{C}$	Drain Current, $V_{GS} @ 10V^3$	-2.4	A
I_{DM}	Pulsed Drain Current ¹	-20	A
$P_D@T_A=25^\circ\text{C}$	Total Power Dissipation ³	2.5	W
E_{AS}	Single Pulse Avalanche Energy ⁴	12.5	mJ
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$

Thermal Data

Symbol	Parameter	Value	Unit
R_{thj-a}	Maximum Thermal Resistance, Junction-ambient ³	50	$^\circ\text{C/W}$

Electrical Characteristics@T_j=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250uA	-100	-	-	V
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =-10V, I _D =-3A	-	-	135	mΩ
		V _{GS} =-4.5V, I _D =-2A	-	-	150	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250uA	-1.3	-	-3	V
g _{fs}	Forward Transconductance	V _{DS} =-5V, I _D =-3A	-	10	-	S
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-80V, V _{GS} =0V	-	-	-25	uA
I _{GSS}	Gate-Source Leakage	V _{GS} =±20V, V _{DS} =0V	-	-	±0.1	uA
Q _g	Total Gate Charge ⁵	I _D =-3A	-	29	46	nC
Q _{gs}	Gate-Source Charge ⁵	V _{DS} =-50V	-	6	-	nC
Q _{gd}	Gate-Drain ("Miller") Charge ⁵	V _{GS} =-10V	-	5	-	nC
t _{d(on)}	Turn-on Delay Time ⁵	V _{DS} =-50V	-	12	-	ns
t _r	Rise Time ⁵	I _D =-1A	-	5	-	ns
t _{d(off)}	Turn-off Delay Time ⁵	R _G =3.3Ω	-	42	-	ns
t _f	Fall Time ⁵	V _{GS} =-10V	-	18	-	ns
C _{iss}	Input Capacitance ⁵	V _{GS} =0V	-	1525	2440	pF
C _{oss}	Output Capacitance ⁵	V _{DS} =-80V	-	53	-	pF
C _{rss}	Reverse Transfer Capacitance ⁵	f=1.0MHz	-	40	-	pF
R _g	Gate Resistance	f=1.0MHz	-	6.3	12.6	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V _{SD}	Forward On Voltage ²	I _S =-1.9A, V _{GS} =0V	-	-	-1.3	V
t _{rr}	Reverse Recovery Time ⁵	I _S =-3A, V _{GS} =0V,	-	24	-	ns
Q _{rr}	Reverse Recovery Charge ⁵	dI/dt=-100A/μs	-	26	-	nC

Notes:

- 1.Pulse width limited by Max. junction temperature.
- 2.Pulse test
- 3.Surface mounted on 1 in² copper pad of FR4 board, t ≤ 10s ; 125 °C/W when mounted on Min. copper pad.
- 4.Starting T_j=25°C , V_{DD}=-50V , L=1mH , R_G=25Ω , V_{GS}=-10V.
- 5.Guaranteed by design.
- 6.These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150°C.

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT, AUTOMOTIVE OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

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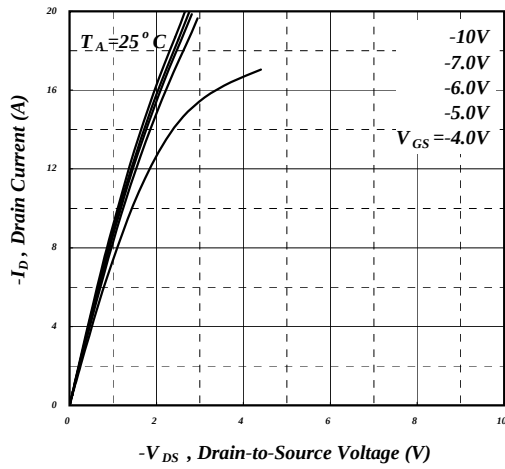


Fig 1. Typical Output Characteristics

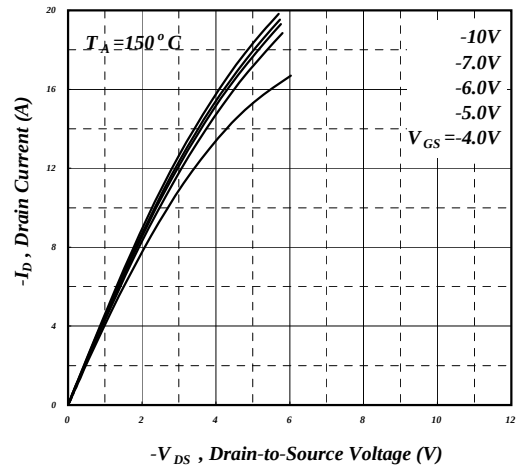


Fig 2. Typical Output Characteristics

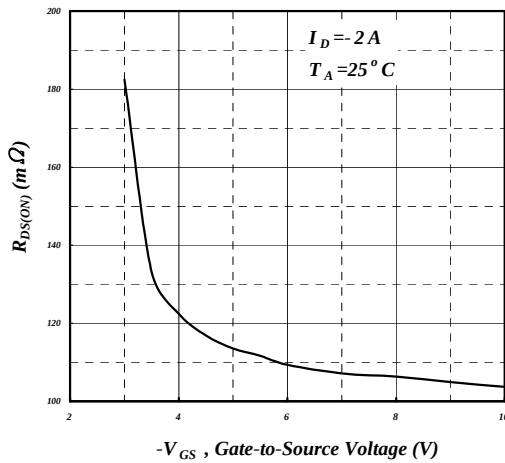
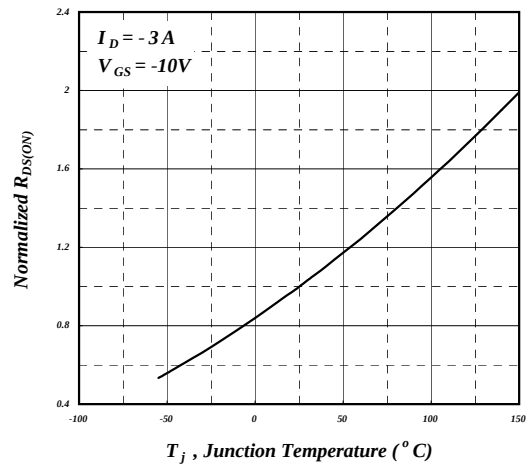
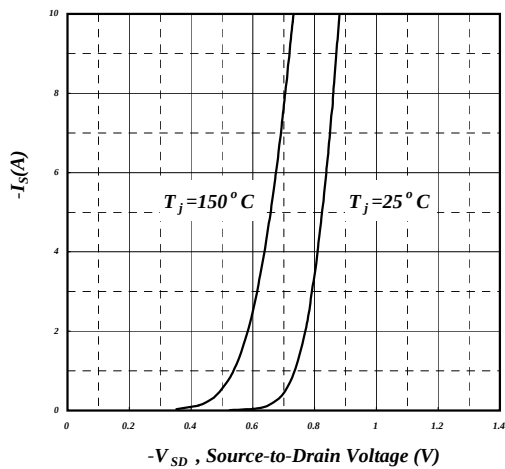


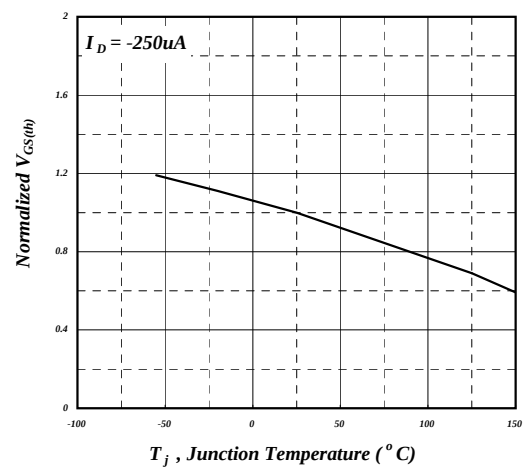
Fig 3. On-Resistance v.s. Gate Voltage



**Fig 4. Normalized On-Resistance
v.s. Junction Temperature**



**Fig 5. Forward Characteristic of
Reverse Diode**



**Fig 6. Gate Threshold Voltage v.s.
Junction Temperature**

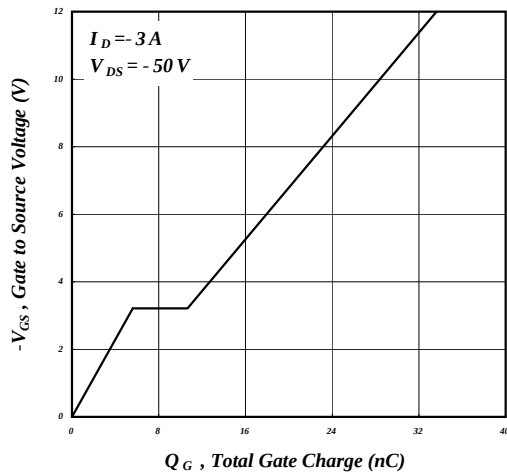


Fig 7. Gate Charge Characteristics

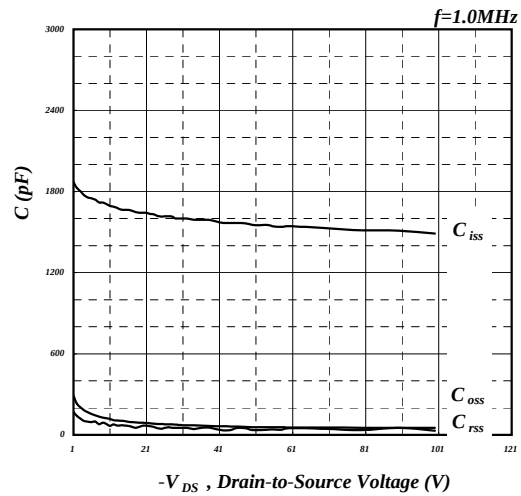


Fig 8. Typical Capacitance Characteristics

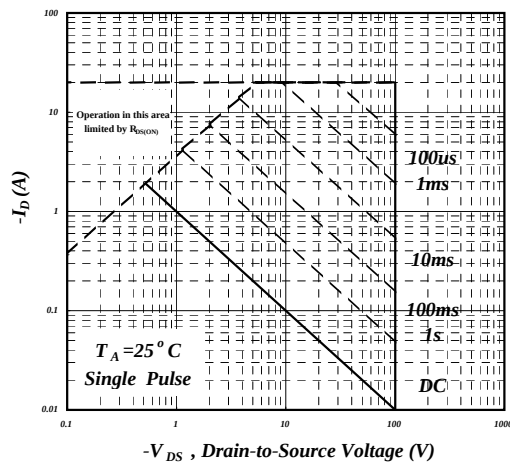


Fig 9. Maximum Safe Operating Area⁶

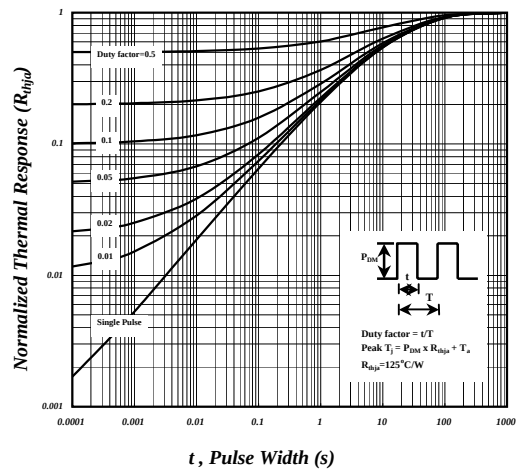


Fig 10. Effective Transient Thermal Impedance

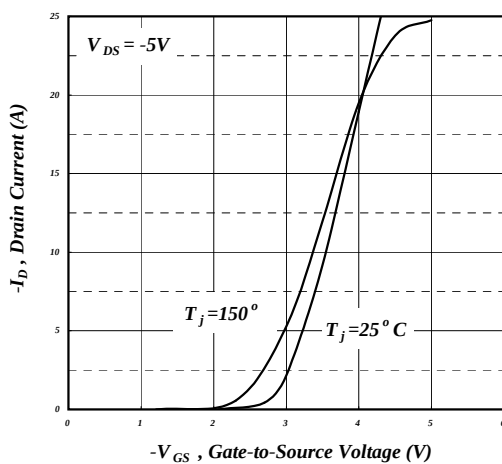


Fig 11. Transfer Characteristics

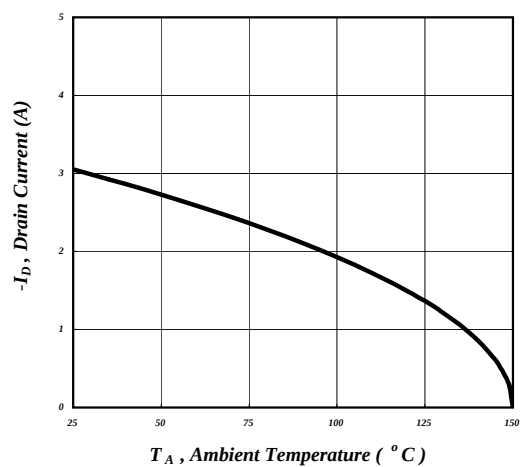


Fig 12. Drain Current v.s. Ambient Temperature

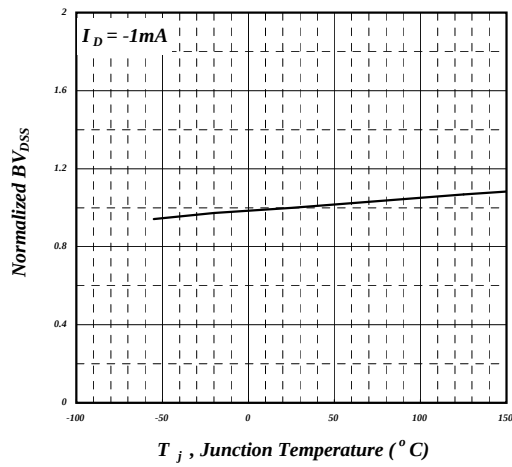


Fig 13. Normalized BV_{DSS} v.s. Junction Temperature

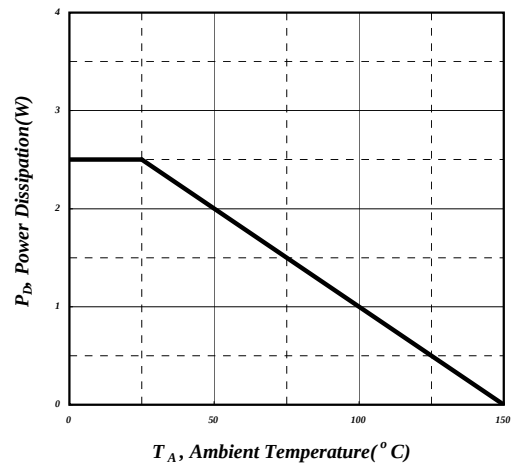


Fig 14. Total Power Dissipation

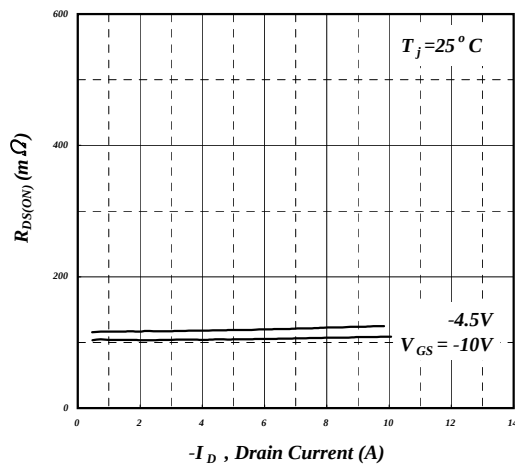
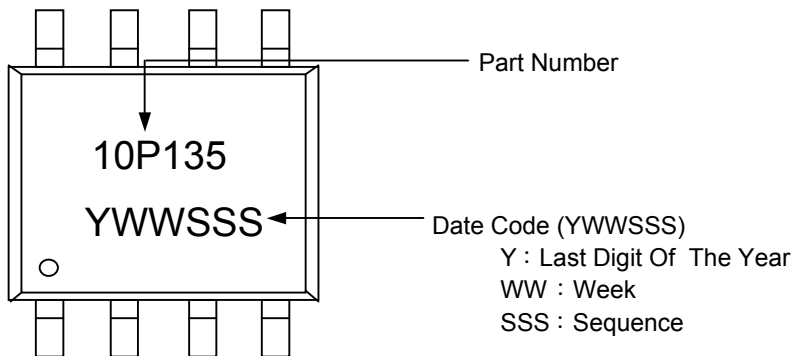
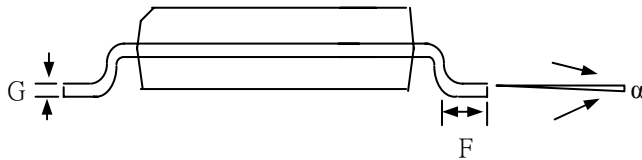
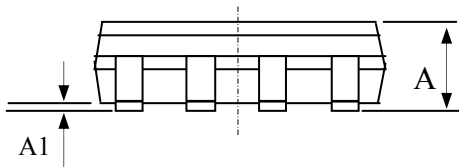
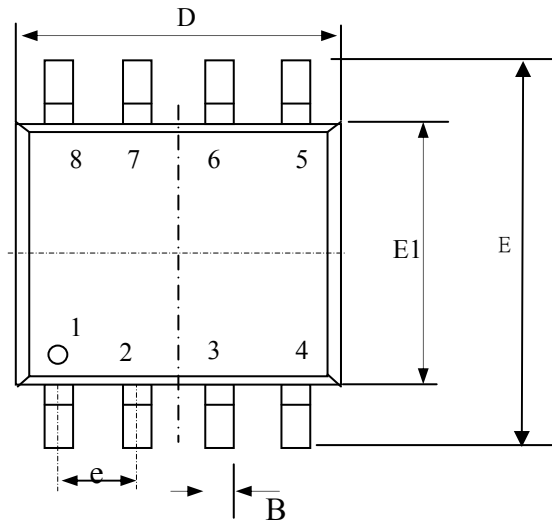


Fig 15. Typ. Drain-Source on State Resistance

MARKING INFORMATION



Package Outline : SO-8



SYMBOLS	Millimeters		
	MIN	NOM	MAX
A	1.35	1.55	1.75
A1	0.05	0.15	0.25
B	0.30	0.41	0.51
D	4.80	5.05	5.30
E	5.79	6.00	6.20
E1	3.70	3.90	4.10
e	1.27 TYP		
G	0.17	0.21	0.25
F	0.38	0.83	1.27
α	0°	4°	8°

- 1.All Dimension Are In Millimeters.
- 2.Dimension Does Not Include Mold Protrusions.

SO-8 FOOTPRINT :

